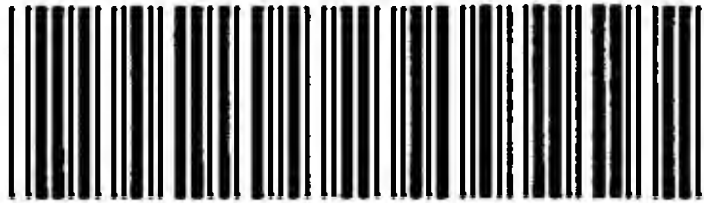


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/511,270	NAKAJIMA ET AL.	
	Examiner	Art Unit	
	Shawn Hamidinia	1653	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
STIC: sequence search (see attached)	8/15/2005	SH
STIC: sequence search (see attached)	3/1/2006	SH